Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/870,180	SMITH ET AL.	
Examiner	Art Unit	
John L. Goff	1733	

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Class	Subclass	Date	Examiner
156	272.2, 273.3, 273.5, 275.7,297	12/11/2002	JĿG
156	298	12/11/2002	JLG
264	1.34	12/11/2002	JLG
264	1.36	12/11/2002	JLG
264	1.38	12/11/2002	JLG
264	1.9	12/11/2002	JLG
264	2.5	12/11/2002	JLG
359	529	12/11/2002	JLG
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Above	UPDATED	5/23/2003	JLG
Above	UPDATED	12/16/2003	JLG
Above	UPDATED	10/14/2005	JLG

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Class	Subclass	Date	Examiner
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